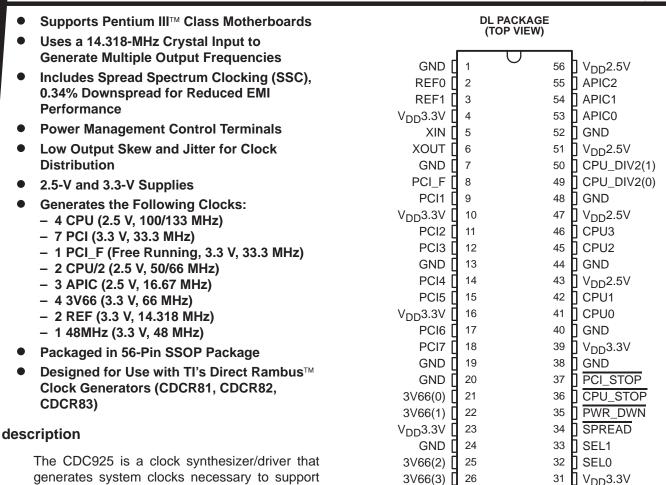
SCAS633 - JULY 28, 1999



3V66, PCI, APIC, 48MHz, and REF clock signals. All output frequencies are generated from a

Intel Pentium III systems on CPU, CPU\_DIV2,

14.318-MHz crystal input. A reference clock input instead of a crystal can be provided at the XIN input. Two phase-locked loops (PLLs) are used, one to generate the host frequencies and the other to generate the 48-MHz clock frequency. On-chip loop filters and internal feedback loops eliminate the need for external components.

 $V_{DD}3.3V$ 

SEL133/100

27

28

The host and PCI clock outputs provide low-skew and low-jitter clock signals for reliable clock operation. All outputs have 3-state capability, which can be selected via control inputs SEL0, SEL1, and SEL133/100.

The outputs are either 3.3-V or 2.5-V single-ended CMOS buffers. With a logic high-level on the PWR DWN terminal, the device operates normally, but when a logical low-level input is applied, the device powers down completely, with the outputs in a low-level output state. When a high-level is applied to the PCI STOP or CPU STOP, the outputs operate normally. With a low-level applied to the PCI STOP or CPU STOP terminals, the PCI or CPU and 3V66 outputs, respectively, are held in a low-level state.

The CPU bus can operate at 100 MHz or 133 MHz. Output frequency selection is done with corresponding setting for SEL133/100 control input. The PCI bus frequency is fixed to 33MHz.



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30

29

1 48MHz

**GND** 

SCAS633 - JULY 28, 1999

#### description (continued)

Since the CDC925 is based on PLL circuitry, it requires a stabilization time to achieve phase lock of the PLL. This stabilization time is required after power up or after changes to the SEL inputs are made. With use of an external reference clock, this signal must be fixed-frequency and fixed-phase before the stabilization time starts.

#### function tables

#### **SELECT FUNCTIONS**

| I              | NPUTS |      |         |          |        | OUTPUTS       | 3      |            |           |                |
|----------------|-------|------|---------|----------|--------|---------------|--------|------------|-----------|----------------|
| SEL133/<br>100 | SEL1  | SEL0 | CPU     | CPU_DIV2 | 3V66   | PCI,<br>PCI_F | 48MHz  | REF        | APIC      | FUNCTION       |
| L              | L     | L    | Hi-Z    | Hi-Z     | Hi-Z   | Hi-Z          | Hi-Z   | Hi-Z       | Hi-Z      | 3-state        |
| L              | L     | Н    | N/A     | N/A      | N/A    | N/A           | N/A    | N/A        | N/A       | Reserved       |
| L              | Н     | L    | 100 MHz | 50 MHz   | 66 MHz | 33 MHz        | Hi-Z   | 14.318 MHz | 16.67 MHz | 48-MHz PLL off |
| L              | Н     | Н    | 100 MHz | 50 MHz   | 66 MHz | 33 MHz        | 48 MHz | 14.318 MHz | 16.67 MHz | 48-MHz PLL on  |
| Н              | L     | L    | TCLK/2  | TCLK/4   | TCLK/4 | TCLK/8        | TCLK/2 | TCLK       | TCLK/16   | Test           |
| Н              | L     | Н    | N/A     | N/A      | N/A    | N/A           | N/A    | N/A        | N/A       | Reserved       |
| Н              | Н     | L    | 133 MHz | 66 MHz   | 66 MHz | 33 MHz        | Hi-Z   | 14.318 MHz | 16.67 MHz | 48-MHz PLL off |
| Н              | Н     | Н    | 133 MHz | 66 MHz   | 66 MHz | 33 MHz        | 48 MHz | 14.318 MHz | 16.67 MHz | 48-MHz PLL on  |

#### **ENABLE FUNCTIONS**

|          | INPUTS  |          |     | OUTPUTS  |      |      |     |       |               |         | RNAL |
|----------|---------|----------|-----|----------|------|------|-----|-------|---------------|---------|------|
| CPU_STOP | PWR_DWN | PCI_STOP | CPU | CPU_DIV2 | APIC | 3V66 | PCI | PCI_F | REF,<br>48MHz | Crystal | VCOs |
| Х        | L       | Х        | L   | L        | L    | L    | L   | L     | L             | Off     | Off  |
| L        | Н       | L        | L   | On       | On   | L    | L   | On    | On            | On      | On   |
| L        | Н       | Н        | L   | On       | On   | L    | On  | On    | On            | On      | On   |
| Н        | Н       | L        | On  | On       | On   | On   | L   | On    | On            | On      | On   |
| Н        | Н       | Н        | On  | On       | On   | On   | On  | On    | On            | On      | On   |

#### **OUTPUT BUFFER SPECIFICATIONS**

|                     | OOTI OT BOTTER               | OI EOII IOATIONO     |             |
|---------------------|------------------------------|----------------------|-------------|
| BUFFER NAME         | V <sub>DD</sub> RANGE<br>(V) | IMPEDANCE $(\Omega)$ | BUFFER TYPE |
| CPU, CPU_DIV2, APIC | 2.375 – 2.625                | 13.5 – 45            | TYPE 1      |
| 48MHz, REF          | 3.135 – 3.465                | 20 – 60              | TYPE 3      |
| PCI, PCI_F, 3V66    | 3.135 - 3.465                | 12 – 55              | TYPE 5      |



## **CDC925** 133-MHz CLOCK SYNTHESIZER/DRIVER FOR PC MOTHERBOARDS WITH 3-STATE OUTPUTS SCAS633 – JULY 28, 1999

#### **Terminal Functions**

| TERMII               | NAL  |     |  |
|----------------------|--|-----|--|
| NAME                 | NO.  | I/O | DESCRIPTION  |
| 3V66 [0-3]           | 21, 22, 25, 26                                     | 0   | 3.3 V, Type 5, 66-MHz clock outputs                        |
| 48MHz                | 30   | 0   | 3.3 V, Type 3, 48-MHz clock output                         |
| APIC [0-2]           | 53, 54, 55   | 0   | 2.5 V, Type 1, APIC clock outputs                          |
| CPU [0-3]            | 41, 42, 45, 46                                     | 0   | 2.5 V, Type 1, CPU clock outputs                           |
| CPU_DIV2 [0-1]       | 49, 50   | 0   | 2.5 V, Type 1, CPU_DIV2 clock outputs                      |
| CPU_STOP             | 36   | I   | Disables CPU clock to low state                            |
| GND                  | 1, 7, 13, 19,<br>20, 24, 29, 38,<br>40, 44, 48, 52 |     | Ground   |
| PCI [1-7]            | 9, 11, 12, 14,<br>15, 17, 18                       | 0   | 3.3 V, Type 5, 33-MHz PCI clock outputs                    |
| PCI_F                | 8  | 0   | Free-running 3.3-V, Type 5, 33-MHz PCI clock output        |
| PCI_STOP             | 37   | I   | Disables PCI clock to low state                            |
| PWR_DWN              | 35   | I   | Power down for complete device with outputs forced low     |
| REF0, REF1           | 2, 3   | 0   | 3.3 V, Type 3, 14.318-MHz reference clock output           |
| SEL0, SEL1           | 32, 33   | I   | LVTTL level logic select terminals for function selection  |
| SEL133/100           | 28   | I   | LVTTL level logic select pins for enabling 100/133 MHz     |
| SPREAD               | 34   | I   | Disables SSC function                                      |
| V <sub>DD</sub> 3.3V | 4, 10, 16, 23,<br>27, 31, 39                       |     | Power for the 3V66, 48MHz, PCI, REF outputs and CORE logic |
| V <sub>DD</sub> 2.5V | 43, 47, 51, 56                                     |     | Power for CPU and APIC outputs                             |
| XIN                  | 5  | I   | Crystal input – 14.318 MHz                                 |
| XOUT                 | 6  | 0   | Crystal output – 14.318 MHz                                |



#### spread spectrum clock (SSC) implementation for CDC925

Simultaneously switching at fixed frequency generates a significant power peak at the selected frequency, which in turn will cause EMI disturbance to the environment. The purpose of the internal frequency modulation of the CPU–PLL allows to distribute the energy to many different frequencies which reduces the power peak. A typical characteristic for a single frequency spectrum and a frequency modulated spectrum is shown in Figure 1.

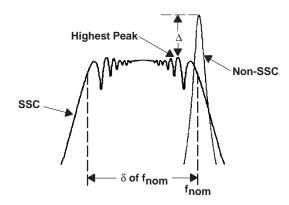


Figure 1. Frequency Power Spectrum With and Without the Use of SSC

The modulated spectrum has its distribution left hand to the single frequency spectrum which indicates a "down-spread modulation".

The peak reduction depends on the modulation scheme and modulation profile. System performance and timing requirements are the limiting factors for actual design implementations. The implementation was driven to keep the average clock frequency closed to its upper specification limit. The modulation amount was set to approximately -0.34% (compared to -0.5% on the CDC924).

In order to allow a downstream PLL to follow the frequency modulated signal, the bandwidth of the modulation signal is limited in order to minimize SSC induced tracking skew jitter. The ideal modulation profile used for CDC925 is shown in Figure 2.

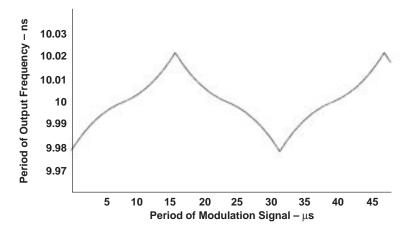
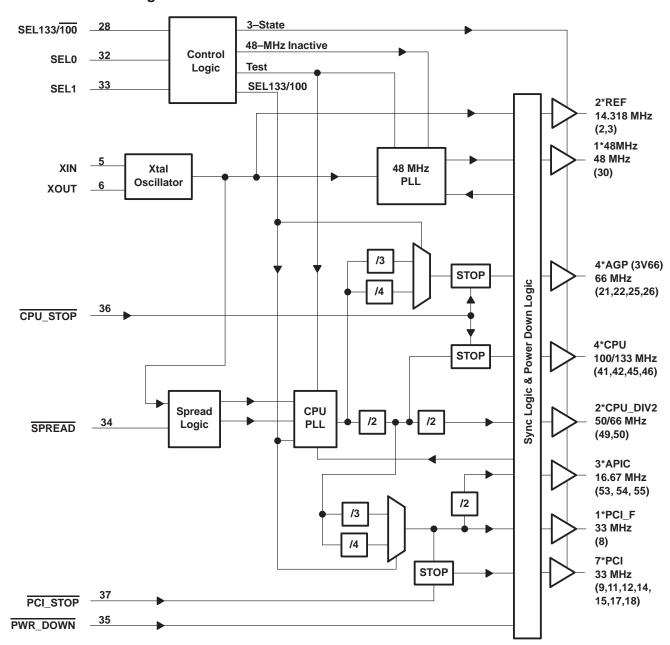


Figure 2. SSC Modulation Profile



#### functional block diagram



SCAS633 - JULY 28, 1999

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

#### **DISSIPATION RATING TABLE**

| PACKAGE | T <sub>A</sub> ≤ 25°C | DERATING FACTOR <sup>†</sup> | T <sub>A</sub> = 70°C | T <sub>A</sub> = 85°C |
|---------|-----------------------|------------------------------|-----------------------|-----------------------|
|         | POWER RATNG           | ABOVE T <sub>A</sub> = 25°C  | POWER RATING          | POWER RATING          |
| DL      | 1558.6 mW             | 12.468 mW/°C                 | 997.5 mW              | 810.52 mW             |

<sup>†</sup> This is the inverse of the traditional junction-to-case thermal resistance (R<sub>θJA</sub>) and uses a board-mounted device at 80.2°C/W.

#### recommended operating conditions (see Note 2)

|   |                    | MIN   | иом†   | MAX   | UNIT |
|---|--------------------|---|--------|---|------|
| Supply voltage Van                        | 3.3 V              | 3.135   |        | 3.465   | V    |
| Supply voltage, V <sub>DD</sub>           | 2.5 V              | 3.135 3.465 2.375 2.625  2 VDD + 0.3 V  GND - 0.8 VDD  0.8 VDD  x -12 -12 -14 Sx -18 x 12 9 Sx 12 130 | V      |   |      |
| High-level input voltage, V <sub>IH</sub> |                    | 2   |        |   | V    |
| Low-level input voltage, V <sub>IL</sub>  |                    |   |        | 0.8   | V    |
| Input voltage, V <sub>I</sub>             |                    | 0   |        | $V_{DD}$  | V    |
|   | CPUx, CPU_DIV2x    |   |        | -12   |      |
| ligh lovel output current love            | APICx              |   |        | -12   | mA   |
| High-level output current, IOH            | 48MHz, REFx        |   |        | -14   | IIIA |
|   | PCIx, PCI_F, 3V66x |   |        | 3.465 2.625  VDD + 0.3 V  0.8  VDD  -12 -12 -14 -18 12 12 9 12 318 14.8 |      |
|   | CPUx, CPU_DIV2x    |   |        | 12  |      |
| Low lovel output output                   | APICx              |   |        | 12  | A    |
| Low-level output current, IOL             | 48MHz, REFx        |   |        | 9   | mA   |
|   | PCIx, PCI_F, 3V66x |   |        | 12  |      |
| Reference frequency, f(XIN) <sup>‡</sup>  | Test mode          |   | 130    |   | MHz  |
| Crystal frequency, f(XTAL)§               | Normal mode        | 13.8  | 14.318 | 14.8  | MHz  |
| Operating free-air temperature, TA        |                    | 0   |        | 85  | °C   |

NOTE 2: Unused inputs must be held high or low to prevent them from floating.



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>†</sup> All nominal values are measured at their respective nominal V<sub>DD</sub> values.

<sup>‡</sup> Reference frequency is a test clock driven on the XIN input during the device test mode and normal mode. In test mode, XIN can be driven externally up to f<sub>(XIN)</sub> = 130 MHz. If XIN is driven externally, XOUT is floating.

<sup>§</sup> This is a series fundamental crystal with  $f_{O} = 14.31818$  MHz.

SCAS633 - JULY 28, 1999

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

|                 | PARAMETER                      |   | TEST CO  | NDITIONS                  | MIN | TYP† | MAX  | UNIT |  |
|-----------------|--------------------------------|---|--|---------------------------|-----|------|------|------|--|
| ۷IK             | Input clamp voltage            |   | V <sub>DD</sub> = 3.135 V,                       | I <sub>I</sub> = -18 mA   |     |      | -1.2 | V    |  |
| R <sub>I</sub>  | Input resistance               | XIN-XOUT  | V <sub>DD</sub> = 3.465 V,                       | $V_{I} = V_{DD} - 0.5 V$  | 80  |      | 350  | kΩ   |  |
|                 |                                | XOUT  | V <sub>DD</sub> = 3.135 V,                       | $V_{I} = V_{DD} - 0.5 V$  |     | 20   | 50   | mA   |  |
| lін             | High-level input current       | SEL0, SEL1,<br>CPU_STOP,<br>PCI_STOP,<br>SPREAD | V <sub>DD</sub> = 3.465 V,                       | $V_I = V_{DD}$            |     | <10  | 10   | μΑ   |  |
|                 |                                | PWR_DWN   | $V_{DD} = 3.465 \text{ V},$                      | $V_I = V_{DD}$            |     | <10  | 10   | μΑ   |  |
|                 |                                | SEL133/100                                      | $V_{DD} = 3.465 \text{ V},$                      | $V_I = V_{DD}$            |     | <10  | 10   | μΑ   |  |
|                 |                                | XOUT  | $V_{DD} = 3.135 V,$                              | VO = 0 V                  |     | -2   | -5   | mA   |  |
| I <sub>IL</sub> | Low-level input current        | SEL0, SEL1,<br>CPU_STOP,<br>PCI_STOP,<br>SPREAD | V <sub>DD</sub> = 3.465 V,                       | V <sub>I</sub> = GND      |     | <10  | -10  | μΑ   |  |
|                 |                                | PWR_DWN   | V <sub>DD</sub> = 3.465 V,                       | $V_I = GND$               |     | <10  | -10  | μΑ   |  |
|                 |                                | SEL133/100                                      | V <sub>DD</sub> = 3.465 V,                       | V <sub>I</sub> = GND      |     | <10  | -10  | μΑ   |  |
| loz             | High-impedance-state output cu | rrent   | V <sub>DD</sub>   = max,                         | $V_O = V_{DD}$ or GND     |     |      | ±10  | μΑ   |  |
|                 |                                |   | V <sub>DD</sub> = 2.625 V,<br>All outputs = low  | PWR_DWN = low,            |     | <20  | 100  |      |  |
| I <sub>DD</sub> | Supply current                 |   | V <sub>DD</sub> = 2.625 V,<br>All outputs = high | $V_{DD}x = 2.5 V,$        |     | <20  | 100  | μΑ   |  |
|                 |                                |   | V <sub>DD</sub> = 3.465 V,<br>All outputs = low  | PWR_DWN = low,            |     | <50  | 200  |      |  |
|                 |                                |   | V <sub>DD</sub> = 3.465 V,                       | All outputs = high        |     | 12   | 35   | mA   |  |
| l== /=:         | High impedance state supply su | rrant   | V <sub>DD</sub> = 2.625 V                        |                           |     |      | 1.4  | mA   |  |
| IDD(Z)          | High-impedance-state supply cu |   | V <sub>DD</sub> = 3.465 V                        |                           |     |      | 28   | IIIA |  |
|                 | Dynamic supply current         |   | C <sub>L</sub> = 20 pF,                          | V <sub>DD</sub> = 3.465 V |     | 114  | 146  | mA   |  |
|                 | Бупапію зирріў сипепі          |   | CPU = 133 MHz                                    | V <sub>DD</sub> = 2.625 V |     | 52   | 70   | IIIA |  |
| Cl              | Input capacitance              |   | V <sub>DD</sub> = 3.3 V,                         | $V_I = V_{DD}$ or GND     | 3.3 |      | 5.8  | pF   |  |
|                 | Crystal terminal capacitance   |   | V <sub>DD</sub> = 3.3 V,                         | V <sub>I</sub> = 0.3 V    | 18  | 18.5 | 22.5 | pF   |  |

<sup>†</sup> All typical values are measured at their respective nominal V<sub>DD</sub> values.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

#### CPUx, CPU\_DIV2x, APICx (Type 1)

|      | PARAMETER                     |            | TEST CO                       | NDITIONS                        | MIN            | TYP <sup>†</sup> | MAX | UNIT |  |
|------|-------------------------------|------------|-------------------------------|---------------------------------|----------------|------------------|-----|------|--|
| Vон  | VOH High-level output voltage |            | V <sub>DD</sub> = min to max, | $I_{OH} = -1 \text{ mA}$        | VDD –<br>0.1 V |                  |     | V    |  |
|      |                               |            | $V_{DD} = 2.375 V$ ,          | I <sub>OH</sub> = -12 mA        | 2              |                  |     |      |  |
| V/01 | Low-level output voltage      |            | V <sub>DD</sub> = min to max, | I <sub>OL</sub> = 1 mA          |                |                  | 0.1 | V    |  |
| VOL  | Low-level output voltage      |            | $V_{DD} = 2.375 V$ ,          | $I_{OL} = 12 \text{ mA}$        |                | 0.18             | 0.4 | V    |  |
|      |                               |            | $V_{DD} = 2.375 V$ ,          | V <sub>O</sub> = 1 V            | -26            | -42              |     |      |  |
| IOH  | IOH High-level output current |            | $V_{DD} = 2.5 V,$             | V <sub>O</sub> = 1.25 V         |                | -46              |     | mA   |  |
|      |                               |            | $V_{DD} = 2.625 V$ ,          | V <sub>O</sub> = 2.375 V        |                | -16              | -27 |      |  |
|      |                               |            | $V_{DD} = 2.375 V$ ,          | V <sub>O</sub> = 1.2 V          | 27             | 57               |     |      |  |
| loL  | Low-level output current      |            | $V_{DD} = 2.5 V$ ,            | V <sub>O</sub> = 1.25 V         |                | 63               |     | mA   |  |
|      |                               |            | $V_{DD} = 2.625 V$ ,          | V <sub>O</sub> = 0.3 V          |                | 23               | 43  |      |  |
| CO   | Output capacitance            |            | $V_{DD} = 3.3 \text{ V},$     | $V_O = V_{DD}$ or GND           | 6              |                  | 8.5 | pF   |  |
| 7-   | Output impedance              | High state | $V_{O} = 0.5 V_{DD}$          | V <sub>O</sub> /I <sub>OH</sub> | 13.5           | 27               | 45  | 0    |  |
| ZO   | Output impedance              | Low state  | $V_{O} = 0.5 V_{DD},$         | V <sub>O</sub> /I <sub>OL</sub> | 13.5           | 20               | 45  | Ω    |  |

<sup>†</sup> All typical values are measured at their respective nominal V<sub>DD</sub> values.

#### 48MHz, REFx (Type 3)

|      | PARAMETER                                |           | TEST CO                       | NDITIONS                        | MIN            | TYP <sup>†</sup> | MAX | UNIT |
|------|--|-----------|-------------------------------|---------------------------------|----------------|------------------|-----|------|
| VOH  | VOH High-level output voltage            |           | V <sub>DD</sub> = min to max, | $I_{OH} = -1 \text{ mA}$        | VDD –<br>0.1 V |                  |     | V    |
|      |  |           | V <sub>DD</sub> = 3.135 V,    | I <sub>OH</sub> = -14 mA        | 2.4            |                  |     |      |
| \/o: | V <sub>OL</sub> Low-level output voltage |           | V <sub>DD</sub> = min to max, | I <sub>OL</sub> = 1 mA          |                |                  | 0.1 | V    |
| VOL  |  |           | $V_{DD} = 3.135 \text{ V},$   | $I_{OL} = 9 \text{ mA}$         |                | 0.18             | 0.4 | V    |
|      |  |           | $V_{DD} = 3.135 \text{ V},$   | V <sub>O</sub> = 1 V            | -27            | -41              |     |      |
| lOH  | OH High-level output current             |           | $V_{DD} = 3.3 \text{ V},$     | V <sub>O</sub> = 1.65 V         |                | -41              |     | mA   |
|      |  |           | V <sub>DD</sub> = 3.465 V,    | V <sub>O</sub> = 3.135 V        |                | -12              | -23 |      |
|      |  |           | $V_{DD} = 3.135 \text{ V},$   | V <sub>O</sub> = 1.95 V         | 29             | 50               |     |      |
| lOL  | Low-level output current                 |           | $V_{DD} = 3.3 \text{ V},$     | V <sub>O</sub> = 1.65 V         |                | 53               |     | mA   |
|      |  |           | V <sub>DD</sub> = 3.465 V,    | V <sub>O</sub> = 0.4 V          |                | 20               | 37  |      |
| CO   | Output capacitance                       |           | $V_{DD} = 3.3 \text{ V},$     | $V_O = V_{DD}$ or GND           | 4.5            |                  | 7   | pF   |
| 7-   | Hi                                       |           | $V_{O} = 0.5 V_{DD}$          | V <sub>O</sub> /I <sub>OH</sub> | 20             | 40               | 60  | Ω    |
| ZO   | Output impedance                         | Low state | $V_{O} = 0.5 V_{DD}$          | V <sub>O</sub> /I <sub>OL</sub> | 20             | 31               | 60  | 52   |

 $<sup>{}^{\</sup>dagger}$  All typical values are measured at their respective nominal V<sub>DD</sub> values.



## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted) (continued)

#### PCIx, PCI\_F, 3V66x (Type 5)

|      | PARAMETER                     |                    | TEST CO                       | NDITIONS                        | MIN            | TYP <sup>†</sup> | MAX | UNIT |
|------|-------------------------------|--------------------|-------------------------------|---------------------------------|----------------|------------------|-----|------|
| Vон  | VOH High-level output voltage |                    | V <sub>DD</sub> = min to max, | $I_{OH} = -1 \text{ mA}$        | VDD –<br>0.1 V |                  |     | V    |
|      |                               |                    | V <sub>DD</sub> = 3.135 V,    | $I_{OH} = -18 \text{ mA}$       | 2.4            |                  |     |      |
| \/a: | Low lovel output voltage      |                    | $V_{DD}$ = min to max,        | $I_{OL} = 1 \text{ mA}$         |                |                  | 0.1 | V    |
| VOL  | Low-level output voltage      |                    | $V_{DD} = 3.135 \text{ V},$   | $I_{OL} = 12 \text{ mA}$        |                | 0.15             | 0.4 | V    |
|      |                               |                    | $V_{DD} = 3.135 \text{ V},$   | V <sub>O</sub> = 1 V            | -33            | -53              |     |      |
| ЮН   | OH High-level output current  |                    | $V_{DD} = 3.3 \text{ V},$     | V <sub>O</sub> = 1.65 V         |                | -53              |     | mA   |
|      |                               |                    | V <sub>DD</sub> = 3.465 V,    | V <sub>O</sub> = 3.135 V        |                | -16              | -33 |      |
|      |                               |                    | $V_{DD} = 3.135 \text{ V},$   | V <sub>O</sub> = 1.95 V         | 30             | 67               |     |      |
| loL  | Low-level output current      |                    | $V_{DD} = 3.3 V,$             | V <sub>O</sub> = 1.65 V         |                | 70               |     | mA   |
|      |                               |                    | V <sub>DD</sub> = 3.465 V,    | V <sub>O</sub> = 0.4 V          |                | 27               | 49  |      |
| CO   | Output capacitance            | Output capacitance |                               | $V_O = V_{DD}$ or GND           | 4.5            |                  | 7.5 | pF   |
| 7-   | Hig                           |                    | $V_{O} = 0.5 V_{DD}$          | Vo/IoH                          | 12             | 31               | 55  | Ω    |
| ZO   | Output impedance              | Low state          | $V_{O} = 0.5 V_{DD}$          | V <sub>O</sub> /I <sub>OL</sub> | 12             | 24               | 55  | 52   |

<sup>†</sup> All typical values are measured at their respective nominal V<sub>DD</sub> values.

## switching characteristics, $V_{DD}$ = 3.135 V to 3.465 V, $T_A$ = 0°C to 85°C

|                   | PARAMETER                           | TEST CONDITIONS              | MIN   | TYP  | MAX                     | UNIT |
|-------------------|-------------------------------------|------------------------------|---|------|-------------------------|------|
|                   | Overshoot/undershoot                |                              | GND – 0.7 V                                   |      | V <sub>DD</sub> + 0.7 V | V    |
|                   | Ring back                           |                              | V <sub>IL</sub> – 0.1 V V <sub>IH</sub> + 0.1 |      | V <sub>IH</sub> + 0.1 V | V    |
|                   | Stabilization time, PWR_DWN to PCIx | f(CPU) = 133 MHz             |   | 0.05 | 3                       | ms   |
| t <sub>dis3</sub> | Disable time, PWR_DWN to PCIx       | f(CPU) = 133 MHz             |   | 50   |                         | ns   |
|                   | Stabilization time, PWR_DWN to CPUx | f <sub>(CPU)</sub> = 133 MHz |   | 0.03 | 3                       | ms   |
| t <sub>dis4</sub> | Disable time, PWR_DWN to CPUx       | f <sub>(CPU)</sub> = 133 MHz |   | 50   |                         | ns   |
|                   | Stabilization time <sup>†</sup>     | After SEL1, SEL0             |   |      | 3                       | ma   |
|                   | Stabilization time                  | After power up               |   |      | 3                       | ms   |

<sup>†</sup> Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. In order for phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at XIN. Until phase lock is obtained, the specifications for propagation delay and skew parameters given in the switching characteristics tables are not applicable. Stabilization time is defined as the time from when VDD achieves its nominal operating level until the output frequency is stable and operating within specification.



SCAS633 - JULY 28, 1999

## switching characteristics, $V_{DD}$ = 2.375 V to 2.625 V, $T_{A}$ = 0°C to 85°C (continued)

#### **CPUx**

|                    | PARAMETER                                   | FROM<br>(INPUT) | TO<br>(OUTPUT) | TEST CONDITIONS                         | MIN | TYP   | MAX  | UNIT |
|--------------------|---|-----------------|----------------|---|-----|-------|------|------|
| t <sub>en1</sub>   | Output enable time                          | SEL133/100      | CPUx           | f <sub>(CPU)</sub> = 100 or 133MHz      |     | 6     | 10   | ns   |
| t <sub>dis1</sub>  | Output disable time                         | SEL133/100      | CPUx           | f <sub>(CPU)</sub> = 100 or 133MHz      |     | 8     | 10   | ns   |
| +.                 | CPU clock period <sup>†</sup>               |                 |                | f(CPU) = 100 MHz                        | 10  | 10.04 | 10.2 | ns   |
| t <sub>C</sub>     | СРО сюск репоат                             |                 |                | f <sub>(CPU)</sub> = 133 MHz            | 7.5 | 7.53  | 7.7  | ns   |
|                    | Cycle to cycle jitter                       |                 |                | f <sub>(CPU)</sub> = 100 or 133MHz      |     |       | 250  | ps   |
|                    | Duty cycle                                  |                 |                | f <sub>(CPU)</sub> = 100 or 133MHz      | 45  |       | 55   | %    |
| t <sub>sk(o)</sub> | CPU bus skew                                | CPUx            | CPUx           | f <sub>(CPU)</sub> = 100 or 133MHz      |     | 50    | 175  | ps   |
| t <sub>sk(p)</sub> | CPU pulse skew                              | CPUn            | CPUn           | f <sub>(CPU)</sub> = 100 or 133MHz      |     |       | 2.2  | ns   |
| t(off)             | CPU clock to APIC clock offset, rising edge | е               |                |   | 1.5 | 2.8   | 4    | ns   |
| t(off)             | CPU clock to 3V66 clock offset, rising edge | е               |                |   | 0   | 0.75  | 1.5  | ns   |
|                    | Pulse duration width, high                  |                 |                | f <sub>(CPU)</sub> = 100 MHz            | 2.6 | 4.3   |      | ns   |
| tw1                | Fuise duration width, mgn                   |                 |                | f <sub>(CPU)</sub> = 133 MHz            | 1.4 | 3.7   |      | 115  |
|                    | Pulse duration width, low                   |                 |                | f <sub>(CPU)</sub> = 100 MHz            | 2.8 | 4.3   |      | ns   |
| tw2                | ruise duration width, low                   |                 |                | f <sub>(CPU)</sub> = 133 MHz            | 1.7 | 4     |      | 115  |
| t <sub>r</sub>     | Rise time                                   |                 | ·              | $V_0 = 0.4 \text{ V to } 2.0 \text{ V}$ | 0.4 | 1.5   | 2.2  | ns   |
| tf                 | Fall time                                   |                 | ·              | V <sub>O</sub> = 0.4 V to 2.0 V         | 0.4 | 1.4   | 2    | ns   |

<sup>†</sup> The average over any 1-µs period of time is greater than the minimum specified period.

#### CPU\_DIV2x

|                  | PARAMETER                                 | FROM<br>(INPUT)                 | TO<br>(OUTPUT)                  | TEST CONDITIONS                    | MIN | TYP   | MAX  | UNIT |
|------------------|---|---------------------------------|---------------------------------|------------------------------------|-----|-------|------|------|
| t <sub>en1</sub> | Output enable time                        | SEL133/100                      | CPU_DIV2x                       | f <sub>(CPU)</sub> = 100 or 133MHz |     | 6     | 10   | ns   |
| tdis1            | Output disable time                       | SEL133/100                      | CPU_DIV2x                       | f(CPU) = 100 or 133MHz             |     | 8     | 10   | ns   |
|                  | CPU_DIV2 clock period <sup>†</sup>        |                                 |                                 | f(CPU) = 100 MHz                   | 20  | 20.08 | 20.4 | ns   |
| t <sub>C</sub>   | CFO_DIV2 clock period                     |                                 |                                 | f <sub>(CPU)</sub> = 133 MHz       | 15  | 15.06 | 15.3 | ns   |
|                  | Cycle to cycle jitter                     |                                 |                                 | f(CPU) = 100 or 133MHz             |     |       | 250  | ps   |
|                  | Duty cycle                                |                                 |                                 | f(CPU) = 100 or 133MHz             | 45  |       | 55   | %    |
| tsk(o)           | CPU_DIV2 bus skew                         | CPU_DIV2x                       | CPU_DIV2x                       | f(CPU) = 100 or 133MHz             |     | 50    | 175  | ps   |
| tsk(p)           | CPU_DIV2 pulse skew                       | CPU_DIV2n                       | CPU_DIV2n                       | f(CPU) = 100 or 133MHz             |     |       | 1.6  | ns   |
|                  | Pulse duration width, high                |                                 |                                 | f(CPU) = 100 MHz                   | 7.1 |       |      | ns   |
| tw1              | ruise duration width, nigh                |                                 |                                 | f(CPU) = 133 MHz                   | 4.7 |       |      | 115  |
|                  | Pulse duration width, low                 |                                 |                                 | f(CPU) = 100 MHz                   | 7.3 | 8.9   |      | ns   |
| ¹w2              | t <sub>w2</sub> Pulse duration width, low |                                 | f <sub>(CPU)</sub> = 133 MHz    | 5                                  | 6.6 |       | 115  |      |
| t <sub>r</sub>   | Rise time                                 |                                 | V <sub>O</sub> = 0.4 V to 2.0 V | 0.4                                | 1.4 | 2     | ns   |      |
| t <sub>f</sub>   | Fall time                                 | V <sub>O</sub> = 0.4 V to 2.0 V | 0.4                             | 1.3                                | 1.8 | ns    |      |      |

<sup>†</sup> The average over any 1-µs period of time is greater than the minimum specified period.



SCAS633 - JULY 28, 1999

## switching characteristics, $V_{DD}$ = 2.375 V to 2.625 V, $T_A$ = 0°C to 85°C (continued)

#### **APIC**

|                    | PARAMETER                                   | FROM<br>(INPUT) | TO<br>(OUTPUT)                      | TEST CONDITIONS                 | MIN  | TYP   | MAX  | UNIT |
|--------------------|---|-----------------|-------------------------------------|---------------------------------|------|-------|------|------|
| ten1               | Output enable time                          | SEL133/100      | APICx                               | f(APIC) = 16.67 MHz             |      | 6     | 10   | ns   |
| <sup>t</sup> dis1  | Output disable time                         | SEL133/100      | APICx                               | f(APIC) = 16.67 MHz             |      | 8     | 10   | ns   |
| t <sub>C</sub>     | APIC clock period <sup>†</sup>              |                 |                                     | f <sub>(APIC)</sub> = 16.67 MHz | 60   | 60.24 | 60.6 | ns   |
|                    | Cycle to cycle jitter                       |                 | f <sub>(CPU)</sub> = 100 or 133 MHz |                                 |      | 400   | ps   |      |
|                    | Duty cycle                                  |                 |                                     | f(APIC) = 16.67 MHz             | 45   |       | 55   | %    |
| tsk(o)             | APIC bus skew                               | APICx           | APICx                               | f(APIC) = 16.67 MHz             |      | 30    | 100  | ps   |
| t <sub>sk(p)</sub> | APIC pulse skew                             | APICn           | APICn                               | f(APIC) = 16.67 MHz             |      |       | 3    | ns   |
| t <sub>(off)</sub> | APIC clock to CPU clock offset, rising edge | APICx           | CPUx                                |                                 | -1.5 |       | -4   | ns   |
| t <sub>w1</sub>    | Pulse duration width, high                  |                 | f <sub>(APIC)</sub> = 16.67 MHz     | 25.5                            | 28   |       | ns   |      |
| t <sub>w2</sub>    | Pulse duration width, low                   |                 | f <sub>(APIC)</sub> = 16.67 MHz     | 25.3                            | 29.2 |       | ns   |      |
| t <sub>r</sub>     | Rise time                                   |                 |                                     | V <sub>O</sub> = 0.4 V to 2 V   | 0.4  | 1.6   | 2.1  | ns   |
| t <sub>f</sub>     | Fall time                                   |                 |                                     | V <sub>O</sub> = 0.4 V to 2 V   | 0.4  | 1.2   | 1.7  | ns   |

<sup>†</sup> The average over any 1-μs period of time is greater than the minimum specified period.

## switching characteristics, $V_{DD}$ = 3.135 V to 3.465 V, $T_A$ = 0°C to 85°C

#### 3V66

| 6<br>8 | 10<br>10            | ns                                   |
|--------|---------------------|--------------------------------------|
| 8      | 10                  |                                      |
|        | 10                  | ns                                   |
| 15.06  | 15.3                | ns                                   |
|        | 400                 | ps                                   |
|        | 55                  | %                                    |
| 50     | 150                 | ps                                   |
|        | 2.6                 | ns                                   |
| -0.75  | -1.5                | ns                                   |
| 2.1    | 3                   | ns                                   |
|        |                     | ns                                   |
|        |                     | ns                                   |
| 1.5    | 2                   | ns                                   |
| 1.5    | 2                   | ns                                   |
|        | -0.75<br>2.1<br>1.5 | 50 150<br>2.6<br>-0.75 -1.5<br>2.1 3 |

<sup>†</sup> The average over any 1-μs period of time is greater than the minimum specified period.



SCAS633 - JULY 28, 1999

## switching characteristics, $V_{DD}$ = 3.135 V to 3.465 V, $T_A$ = 0°C to 85°C (continued)

#### 48MHz

|                   | PARAMETER                       | FROM<br>(INPUT) | TO<br>(OUTPUT)                | TEST CONDITIONS                     | MIN  | TYP   | MAX  | UNIT |
|-------------------|---------------------------------|-----------------|-------------------------------|-------------------------------------|------|-------|------|------|
| t <sub>en1</sub>  | Output enable time              | SEL133/100      | 48MHz                         | f <sub>(48MHz)</sub> = 48 MHz       |      | 6     | 10   | ns   |
| <sup>t</sup> dis1 | Output disable time             | SEL133/100      | 48MHz                         | f <sub>(48MHz)</sub> = 48 MHz       |      | 8     | 10   | ns   |
| t <sub>C</sub>    | 48MHz clock period <sup>†</sup> |                 |                               | f <sub>(48MHz)</sub> = 48 MHz       | 20.5 | 20.83 | 21.1 | ns   |
|                   | Cycle to cycle jitter           |                 |                               | f <sub>(CPU)</sub> = 100 or 133 MHz |      |       | 500  | ps   |
|                   | Duty cycle                      |                 | _                             | f <sub>(48MHz)</sub> = 48 MHz       | 45   |       | 55   | %    |
| tsk(p)            | 48MHz pulse skew                | 48MHz           | 48MHz                         | f <sub>(48MHz)</sub> = 48 MHz       |      |       | 3    | ns   |
| t <sub>w1</sub>   | Pulse duration width, high      |                 | f <sub>(48MHz)</sub> = 48 MHz | 7.8                                 |      |       | ns   |      |
| t <sub>w2</sub>   | Pulse duration width, low       |                 | f <sub>(48MHz)</sub> = 48 MHz | 7.8                                 |      |       | ns   |      |
| t <sub>r</sub>    | Rise time                       |                 |                               | V <sub>O</sub> = 0.4 V to 2 V       | 1    | 2.1   | 2.8  | ns   |
| t <sub>f</sub>    | Fall time                       |                 |                               | $V_0 = 0.4 \text{ V to 2 V}$        | 1    | 1.9   | 2.8  | ns   |

<sup>†</sup> The average over any 1-μs period of time is greater than the minimum specified period.

#### **REF**

|                    | PARAMETER                     | FROM<br>(INPUT) | TO<br>(OUTPUT)                  | TEST CONDITIONS                     | MIN   | TYP  | MAX | UNIT |
|--------------------|-------------------------------|-----------------|---------------------------------|-------------------------------------|-------|------|-----|------|
| t <sub>en1</sub>   | Output enable time            | SEL133/100      | REFx                            | f <sub>(REF)</sub> = 14.318 MHz     |       | 6    | 10  | ns   |
| t <sub>dis1</sub>  | Output disable time           | SEL133/100      | REFx                            | f <sub>(REF)</sub> = 14.318 MHz     |       | 8    | 10  | ns   |
| t <sub>C</sub>     | REF clock period <sup>†</sup> |                 | f <sub>(REF)</sub> = 14.318 MHz |                                     | 69.84 |      | ns  |      |
|                    | Cycle to cycle jitter         |                 |                                 | f <sub>(CPU)</sub> = 100 or 133 MHz |       |      | 700 | ps   |
|                    | Duty cycle                    |                 |                                 | f <sub>(REF)</sub> = 14.318 MHz     | 45    |      | 55  | %    |
| t <sub>sk(o)</sub> | REF bus skew                  | REFx            | REFx                            | f <sub>(REF)</sub> = 14.318 MHz     |       | 150  | 250 | ps   |
| tsk(p)             | REF pulse skew                | REFn            | REFn                            | f <sub>(REF)</sub> = 14.318 MHz     |       |      | 2   | ns   |
| t <sub>w1</sub>    | Pulse duration width, high    |                 |                                 | f <sub>(REF)</sub> = 14.318 MHz     | 26.2  | 32.7 |     | ns   |
| t <sub>w2</sub>    | Pulse duration width, low     |                 | f <sub>(REF)</sub> = 14.318 MHz | 26.2                                | 31.2  |      | ns  |      |
| t <sub>r</sub>     | Rise time                     |                 |                                 | V <sub>O</sub> = 0.4 V to 2 V       | 1     | 2    | 2.8 | ns   |
| tf                 | Fall time                     |                 |                                 | V <sub>O</sub> = 0.4 V to 2 V       | 1     | 1.9  | 2.8 | ns   |

<sup>†</sup> The average over any 1-μs period of time is greater than the minimum specified period.



SCAS633 - JULY 28, 1999

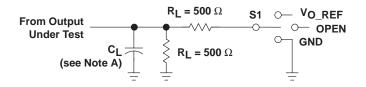
## switching characteristics, $V_{DD}$ = 3.135 V to 3.465 V, $T_A$ = 0°C to 85°C (continued)

## PCI, PCI\_F

|                    | PARAMETER                       | FROM<br>(INPUT) | TO<br>(OUTPUT)              | TEST CONDITIONS                     | MIN  | TYP   | MAX  | UNIT |
|--------------------|---------------------------------|-----------------|-----------------------------|-------------------------------------|------|-------|------|------|
| ten1               | Output enable time              | SEL133/100      | PCIx                        | f <sub>(PCI)</sub> = 33 MHz         |      | 6     | 10   | ns   |
| tdis1              | Output disable time             | SEL133/100      | PCIx                        | f <sub>(PCI)</sub> = 33 MHz         |      | 8     | 10   | ns   |
| t <sub>C</sub>     | PCIx clock period <sup>†</sup>  |                 |                             | f <sub>(PCI)</sub> = 33 MHz         | 30   | 30.12 | 30.5 | ns   |
|                    | Cycle to cycle jitter           |                 |                             | f <sub>(CPU)</sub> = 100 or 133 MHz |      |       | 300  | ps   |
|                    | Duty cycle                      |                 |                             | f <sub>(PCI)</sub> = 33 MHz         | 45   |       | 55   | %    |
| t <sub>sk(o)</sub> | PCIx bus skew                   | PCIx            | PCIx                        | f <sub>(PCI)</sub> = 33 MHz         |      | 70    | 300  | ps   |
| t <sub>sk(p)</sub> | PCIx pulse skew                 | PCIn            | PCIn                        | f(PCI) = 33 MHz                     |      |       | 4    | ns   |
| t(off)             | PCIx clock to 3V66 clock offset |                 |                             |                                     | -1.2 |       | -3   | ns   |
| t <sub>w1</sub>    | Pulse duration width, high      |                 | f <sub>(PCI)</sub> = 33 MHz | 12                                  |      |       | ns   |      |
| t <sub>w2</sub>    | Pulse duration width, low       |                 | f <sub>(PCI)</sub> = 33 MHz | 12                                  |      |       | ns   |      |
| t <sub>r</sub>     | Rise time                       |                 |                             | V <sub>O</sub> = 0.4 V to 2 V       | 0.5  | 1.6   | 2    | ns   |
| t <sub>f</sub>     | Fall time                       |                 |                             | V <sub>O</sub> = 0.4 V to 2 V       | 0.5  | 1.5   | 2    | ns   |

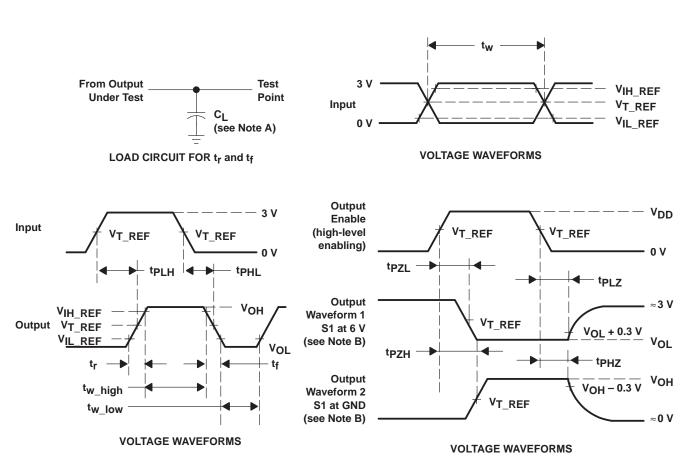
<sup>†</sup> The average over any 1-µs period of time is greater than the minimum specified period.

#### PARAMETER MEASUREMENT INFORMATION



| TEST      | S1                 |
|-----------|--------------------|
| tPLH/tPHL | Open               |
| tPLZ/tPZL | V <sub>O_REF</sub> |
| tPHZ/tPZH | GND                |

LOAD CIRCUIT for tpd and tsk



NOTES: A. C<sub>L</sub> includes probe and jig capacitance. C<sub>L</sub> = 20 pF (CPUx, APICx, 48MHz, REF), C<sub>L</sub> = 30 pF (PCIx, 3V66)

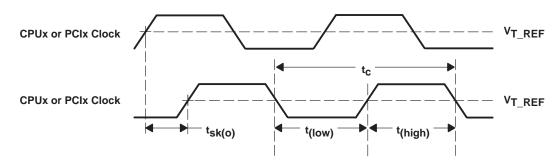
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  14.318 MHz,  $Z_O = 50 \Omega$ ,  $t_r \leq 2.5 \text{ ns}$ ,  $t_f \le 2.5 \text{ ns.}$
- D. The outputs are measured one at a time with one transition per measurement.

|         | PARAMETER                         | 3.3-V INTERFACE | 2.5-V INTERFACE | UNIT |
|---------|-----------------------------------|-----------------|-----------------|------|
| VIH_REF | High-level reference voltage      | 2.4             | 2               | V    |
| VIL_REF | Low-level reference voltage       | 0.4             | 0.4             | V    |
| VT_REF  | Input Threshold reference voltage | 1.5             | 1.25            | V    |
| VO_REF  | Off-state reference voltage       | 6               | 4.6             | V    |

Figure 3. Load Circuit and Voltage Waveforms



#### PARAMETER MEASUREMENT INFORMATION



$$t_{sk(p)} = |t_{PLH}^{-t}_{PHL}|$$

Duty Cycle = 
$$\frac{t(low or high)}{t_c} \times 100$$

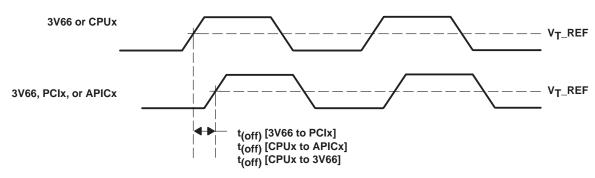
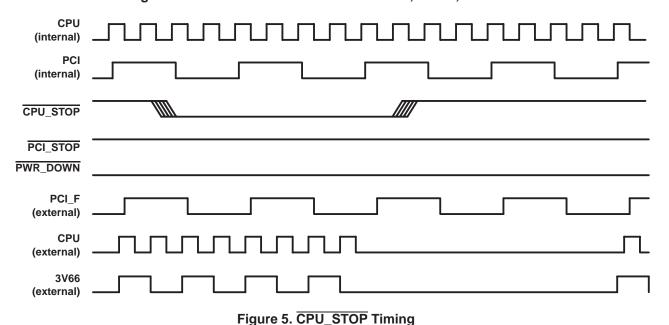
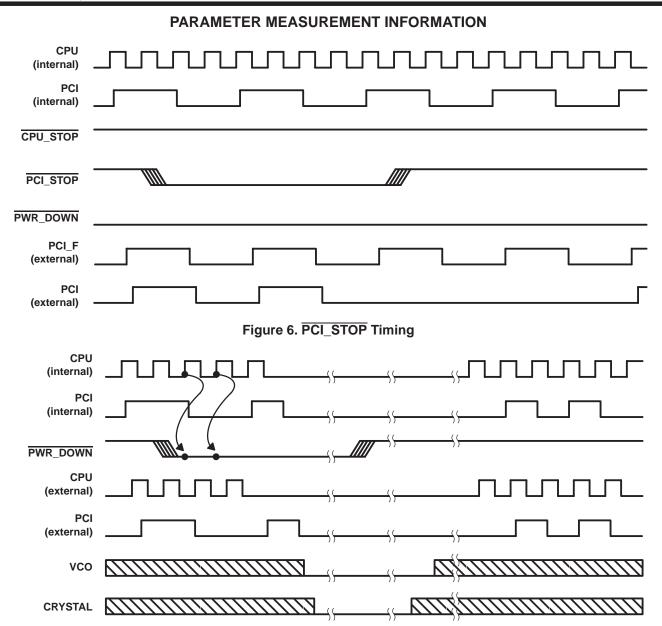


Figure 4. Waveforms for Calculation of Skew, Offset, and Jitter



TEXAS INSTRUMENTS

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NOTE A: Shaded sections on the VCO and Crystal waveforms indicate that the VCO and crystal oscillators are active and there is a valid clock.

Figure 7. Power-Down Timing

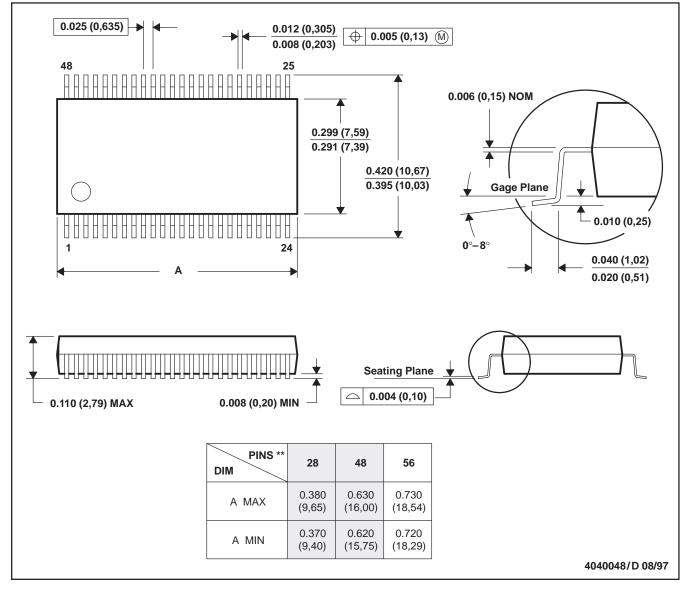


#### **MECHANICAL DATA**

#### DL (R-PDSO-G\*\*)

#### **48-PIN SHOWN**

#### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: B. All linear dimensions are in inches (millimeters).

C. This drawing is subject to change without notice.

D. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

E. Falls within JEDEC MO-118





.com 8-Jan-2007

#### PACKAGING INFORMATION

| Orderable Device | Status <sup>(1)</sup> | Package<br>Type | Package<br>Drawing | Pins | Package<br>Qty | e Eco Plan <sup>(2)</sup> | Lead/Ball Finish | MSL Peak Temp <sup>(3)</sup> |
|------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| CDC925DL         | ACTIVE                | SSOP            | DL                 | 56   | 20             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CDC925DLG4       | ACTIVE                | SSOP            | DL                 | 56   | 20             | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CDC925DLR        | ACTIVE                | SSOP            | DL                 | 56   | 1000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |
| CDC925DLRG4      | ACTIVE                | SSOP            | DL                 | 56   | 1000           | Green (RoHS & no Sb/Br)   | CU NIPDAU        | Level-2-260C-1 YEAR          |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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| DSP                | dsp.ti.com             | Broadband          | www.ti.com/broadband      |
| Interface          | interface.ti.com       | Digital Control    | www.ti.com/digitalcontrol |
| Logic              | logic.ti.com           | Military           | www.ti.com/military       |
| Power Mgmt         | power.ti.com           | Optical Networking | www.ti.com/opticalnetwork |
| Microcontrollers   | microcontroller.ti.com | Security           | www.ti.com/security       |
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